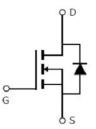


Main Product Characteristics:

V _{DSS}	600V
R _{DS} (on)	2.0Ω (typ.)
I _D	4A







TO-252

Marking and pin
Assignment

Schematic diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute max Rating:

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V(1)	4		
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V1	2.53	Α	
I _{DM}	Pulsed Drain Current②	16		
P _D @TC = 25°C	Power Dissipation③	48	W	
PD @ IC = 25 C	Linear Derating Factor	0.384	W/°C	
V _{DS}	Drain-Source Voltage	600	V	
V _{GS}	/ _{GS} Gate-to-Source Voltage			
E _{AS} Single Pulse Avalanche Energy @ L=25.9mH		117	mJ	
I _{AS}	Avalanche Current @ L=25.9mH	3	А	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C	





Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-case③	_	2.6	°C/W
$R_{\theta JA}$	Junction-to-ambient (t \leq 10s) (4)	_	62.5	°C/W

Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source breakdown voltage		_	_	V	V _{GS} = 0V, ID = 250μA	
D	Static Drain-to-Source on-resistance	_	2.0	2.5	Ω	V _{GS} =10V,I _D = 2A	
R _{DS(on)}	Static Diani-to-Source on-resistance	_	4.43	_	12	T _J = 125℃	
V	Gate threshold voltage	2	_	4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
$V_{GS(th)}$	Gate threshold voltage	_	2.37	_	V	T _J = 125℃	
la a a	Drain to Source leakage current	_	_	1		$V_{DS} = 600V, V_{GS} = 0V$	
I _{DSS}	Drain-to-Source leakage current	_	_	50	μA	T _J = 125℃	
1	Cata to Source forward lookage	_	_	100	nA	V _{GS} =30V	
I_{GSS}	Gate-to-Source forward leakage	_	_	-100		V _{GS} = -30V	
Qg	Total gate charge	_	11.9	_		$I_D = 4A$,	
Q_{gs}	Gate-to-Source charge	_	4.0	_	nC	V _{DS} =480V,	
Q_{gd}	Gate-to-Drain("Miller") charge	_	3.1	_		V _{GS} = 10V	
t _{d(on)}	Turn-on delay time	_	11.0	_			
t _r	Rise time	_	13.5	_		V_{GS} =10V, VDS=300V, R_{GEN} =25 Ω , ID=4A	
t _{d(off)}	Turn-Off delay time	_	38.4	_	ns		
t _f	Fall time	_	19.7	_			
C _{iss}	Input capacitance	_	652	_		V _{GS} = 0V	
Coss	Output capacitance	_	57	_	pF	V _{DS} = 25V	
C _{rss}	Reverse transfer capacitance	_ 5.1			f = 1MHz		

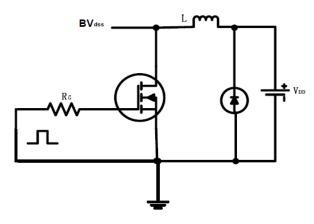
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current		_	4	А	MOSFET symbol
I _S	(Body Diode)	_				showing the
I _{SM}	Pulsed Source Current		_	16	А	integral reverse
	(Body Diode)	_				p-n junction diode.
V _{SD}	Diode Forward Voltage	_	_	1.4	V	I _S =4A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	532	_	nS	$T_J = 25^{\circ}\text{C}, I_F = 4\text{A},$
Qrr	Reverse Recovery Charge	_	1860	_	nC	di/dt = 100A/µs

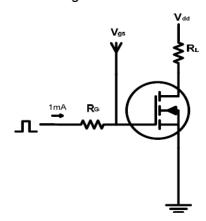


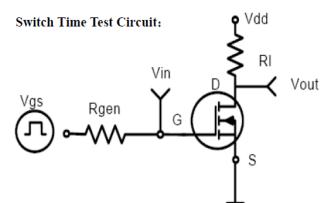
Test circuits and Waveforms

EAS test circuits:

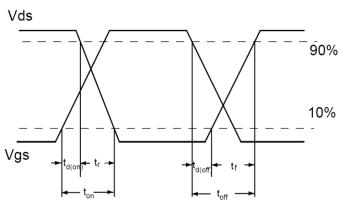


Gate charge test circuit:





Switch Waveforms:



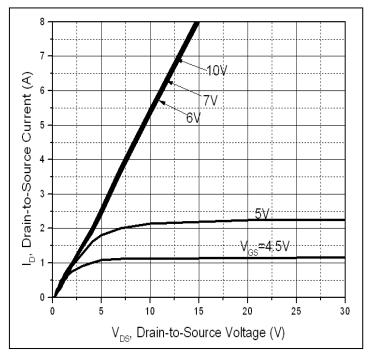
Version: 1.0

Notes:

- ①The maximum current rating is limited by bond-wires.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4 The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



Typical electrical and thermal characteristics



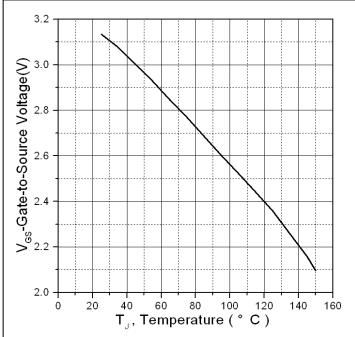
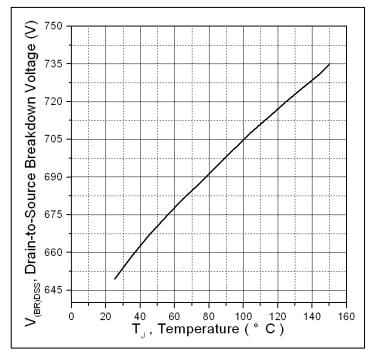
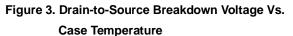


Figure 1: Typical Output Characteristics







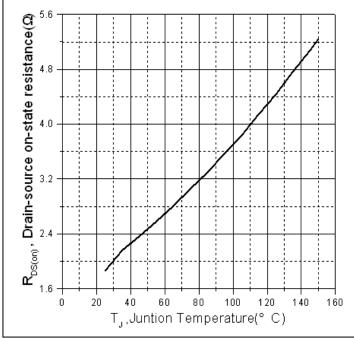
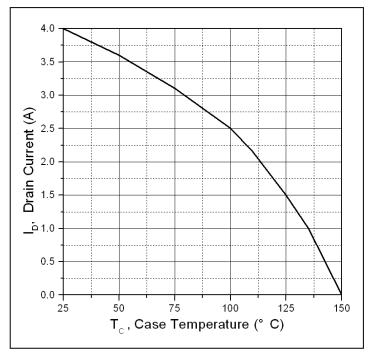


Figure 4: Normalized On-Resistance Vs. Case Temperature





Typical electrical and thermal characteristics



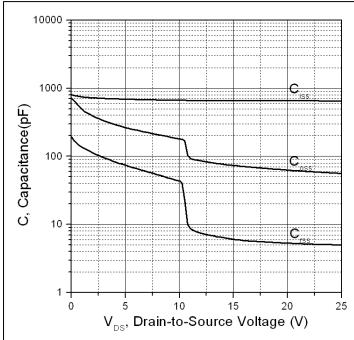


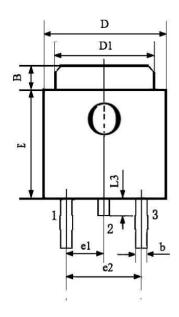
Figure 5. Maximum Drain Current Vs. Case Temperature

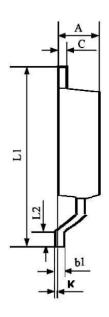
Figure 6.Typical Capacitance Vs. Drain-to-Source Voltage



Mechanical Data:

TO-252 PACKAGE OUTLINE DIMENSION





Symbol	Dimension In Millimeters			Dimension In Inches		
Symbol	Min Nom Ma		Max	Min	Nom	Max
Α	2.200	-	2.400	0.087	-	0.094
В	0.950	-	1.250	0.037	-	0.049
b	0.500	-	0.700	0.020	-	0.028
b1	0.450	-	0.550	0.018	-	0.022
С	0.450	-	0.550	0.018	-	0.022
D	6.450	-	6.750	0.254	-	0.266
D1	5.200	-	5.400	0.205	-	0.213
Е	5.950	-	6.250	0.234	-	0.246
e1	2.240	-	2.340	0.088	-	0.092
e2	4.430	-	4.730	0.174	-	0.186
L1	9.450	-	9.950	0.372	-	0.392
L2	1.250	-	1.750	0.049	-	0.069
L3	0.600	-	0.900	0.024	-	0.035
K	0.000	-	0.100	0.000	-	0.004





Ordering and Marking Information

Device Marking: SSF4N60D

Package (Available)
TO-252 (DPAK)
Operating Temperature Range
C: -55 to 150 °C

Devices per Unit (options)

Package	Units/Tape	Tapes/Inner	Units/Inner	Inner	Units/Carton
Type		Box	Box	Boxes/Carton	Box
				Box	
TO-252	2500	2	5000	7	35000
TO-252	2500	1	2500	10	25000
TO-252	800	5	4000	8	32000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			





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